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802 **Erratum: “Compositional tailored sol-gel SiO₂-TiO₂ thin films: Crystallization, chemical bonding configuration, and optical properties” [J. Mater. Res. 20, 3141 (2005)]**

Li-Lan Yang, Yi-Sheng Lai,
J.S. Chen, P.H. Tsai, C.L. Chen,
C. Jason Chang